Implementing Dopant-Free Hole-Transporting Layers and Metal-Incorporated CsPbI₂Br for Stable All-Inorganic Perovskite Solar Cells

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ABSTRACT: Mixed-halide CsPbI₂Br perovskite is promising for efficient and thermally stable all-inorganic solar cells; however, the use of conventional antisolvent methods and additives-based hole-transporting layers (HTLs) currently hampers progress. Here, we have employed hot-air-assisted perovskite deposition in ambient condition to obtain high-quality photoactive CsPbI₂Br perovskite films and have extended stable device operation using metal cation doping and dopant-free hole-transporting materials. Density functional theory calculations are used to study the structural and optoelectronic properties of the CsPbI₂Br perovskite when it is doped with metal cations Eu²⁺ and In³⁺. We experimentally incorporated Eu²⁺ and In³⁺ metal ions into CsPbI₂Br films and applied dopant-free copper(I) thiocyanate (CuSCN) and poly(3-hexylthiophene) (P3HT)-based materials as low-cost hole transporting layers, leading to record-high power conversion efficiencies of 15.27% and 15.69%, respectively, and a retention of >95% of the initial efficiency over 1600 h at 85 °C thermal stress.

Organic–inorganic hybrid perovskite solar cells have recently demonstrated power conversion efficiencies (PCEs) exceeding 25.5% using tunable, mixed halide and cation perovskite compositions. Recent works demonstrated substantial improvement in the stability of multication organic–inorganic hybrid perovskite solar cells (PSCs) through different approaches. However, champion devices are generally based on volatile organic cations methylammonium (MA) or formamidinium (FA) organic cations, motivating research into relatively more stable all-inorganic alternatives. Consequently, solar cells based on CsPbX₃ perovskites (where X = I, Br, or Cl), and in particular iodine-rich compositions (CsPbI₃ band gap is ∼1.7 eV), have attracted great interest. However, issues remain with regard to securing a functional CsPbI₃-based perovskite, because of a strong tendency for its high-temperature black phases (α, β, or γ) to destabilize to an optically inactive, nonperovskite structure (δ) under ambient conditions.

Photoactive β-CsPbI₃ or γ-CsPbI₃ phases have been stabilized at room temperature using CHI-treatment and dimethylammonium iodide (DMAI) additives, demonstrating their potential for a high PCE of 19%. Therefore, researchers are actively exploring different material compositions, with swapping I for relatively smaller Br halide atoms being a popular choice because of the resulting increase in the Goldschmidt tolerance factor.

Utilizing mixed-halide CsPbI₂Br perovskites is a promising avenue toward improving phase stability while retaining a solar-friendly band gap energy (Eₚ ≈ 1.9 eV), and they are suitable for tandem, or even triple-junction architectures. However, the key challenge is to synthesize device-ready CsPbI₂Br thin films under ambient conditions without environmentally hazardous antisolvents. Reduced dimensions, solvent engineering strategies, and metal ion doping are promising approaches for stabilizing photoactive CsPbI₂Br thin films, though they remain vulnerable to so-called moisture attack. Alternatively, to overcome the issues associated with ambient processing, hot-air-assisted fabrication has emerged as a compelling remedy.

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Thus far, the most efficient all-inorganic perovskite solar cells have been realized using hole-transporting layers (HTls) doped with additives which are used to regulate hole mobility and, hence, performance. For instance, poly [bis(4-phenyl)-(2,4,6-trimethylphenyl)amine] (PTAA) with LiTFSI (bis(trifluoromethane)sulfonyamide lithium salt) and TBP (4-tertbutilpyridine) can act as efficient HTls and have the added benefit of enhancing air stability. However, doped HTls generally incur a high cost and increase the overall processing requirements for devices. To address this economical impairment, low-cost, dopant-free HTls which are also hydrophobic are required.\(^37\)-\(^39\) For the case of all-inorganic CsPbI\(_3\)Br-based PSC, the use of poly[(dithieno[3,2-b:2,3-d]silolethieno[3,4-c]pyrrole-4,6-dione)-random-(2,2′-bithiophenethieno[3,4-c]-pyrrole-4,6-dione)] (poly(DTSTPD-r-BThTPD)) \(^40\) and a dopant-free donor–acceptor polymer poly(DTSTPD-r-BThTPD) have demonstrated good PCE.\(^31\) However, the synthesis of poly(DTSTPD-r-BThTPD) is tedious and the issue of cost still remains. Therefore, alternative HTls such as CuSCN or P3HT are a promising choice.\(^39\)\(^,\)\(^42\) The use of cost-effective organic HTls, like P3HT, are well-known to produce low open-circuit voltage \((V_{OC})\) due to nonradiative recombination at the poorly contacting perovskite/HTl interface.\(^39\)\(^,\)\(^42\) In contrast, using highly uniform films produced via hot-air fabrication could mitigate these impairments by ensuring good contact between the layers.

Recently, Li et al. used P3HT for CsPbI\(_3\)Br-based PSC and boosted the PCE from 14.08% to 15.50% using poly[(9,9-dioctylfluorenyl-2,7-diyldi)-(4,4′-(N-(4-tertbutilphenyl)-diphenylamine)] (TFB) as a wide-band gap buffer layer.\(^43\) With respect to the use of low-cost, dopant-free HTls, the highest PCEs reached thus far are 14.08% (for CsPbI\(_3\)Br) and 11.8% PCE (CsPbI\(_3\)) using P3HT and CuSCN, respectively.\(^36\)\(^,\)\(^45\) Because of its cost-effective nature, high thermal stability, and simplistic preparation, we have selected these promising dopant-free HTls within the CsPbI\(_2\)Br-based PSCs we report here.

In this work, the hot-air method is used for the fabrication of pinhole-free CsPbI\(_3\)Br, CsPbI\(_{0.96}\)Eu\(_{0.04}\)I\(_2\)Br, and InCl\(_3\)/CsPbI\(_2\)Br perovskite thin films in order to improve their stability under ambient conditions. Highly uniform perovskite thin films facilitate excellent perovskite/HTl interfaces, enabling high-efficiency dopant-free HTl-based solar cells. Further incorporating Eu\(^{2+}\) and In\(^{3+}\) metal enhances device stability with PCEs recorded up to 15.27% and 15.69%, respectively, for CuSCN and P3HT HTls. Importantly, these devices retain >95% of their initial PCE over 1600 h of operation in ambient conditions.

We begin by investigating the electronic band structures of the pristine and doped (Eu and In) CsPbI\(_3\)Br materials using density functional theory (DFT) calculations (details are provided in the Supporting Information). Substituting one Pb\(^{2+}\) ion by either an Eu\(^{2+}\) or In\(^{3+}\) ion within a simulated supercell resulted in compositions CsPb\(_{0.96}\)Eu\(_{0.04}\)I\(_2\)Br and CsPb\(_{0.95}\)In\(_{0.05}\)I\(_2\)Br, respectively (Figure 1a–c). The lattice parameter of a CsPbI\(_3\)Br 3 × 3 × 3 supercell is predicted to be \(a = 18.903 \text{ Å}\), compared to the slightly smaller lattice parameter of CsPb\(_{0.95}\)In\(_{0.05}\)I\(_2\)Br (\(a = 18.895 \text{ Å}\)) and CsPb\(_{0.96}\)Eu\(_{0.04}\)I\(_2\)Br (\(a = 18.878 \text{ Å}\)), consistent with the relative change in ionic radii (Eu\(^{2+}\), 1.12 Å; In\(^{3+}\), 0.91 Å; and Pb\(^{2+}\), 1.19 Å) in 6-fold coordination. The thermodynamic stability of Eu- and In-doped CsPbI\(_3\)Br materials was examined by calculating the binding energy \((E_B)\) with respect to the decomposed constituent atoms using the relation

\[
E_B = \frac{(E_{\text{total}} - n_{\text{Cs}}E_{\text{atom}}^{\text{Cs}} - n_{\text{Pb}}E_{\text{atom}}^{\text{Pb}} - n_{\text{I}}E_{\text{atom}}^{\text{I}} - n_{\text{Eu}}E_{\text{atom}}^{\text{Eu}} - n_{\text{In}}E_{\text{atom}}^{\text{In}}) - (n_{\text{Cs}} + n_{\text{Pb}} + n_{\text{I}} + n_{\text{Eu}} + n_{\text{In}})}{n_{\text{Cs}} + n_{\text{Pb}} + n_{\text{I}} + n_{\text{Eu}} + n_{\text{In}}}
\]

Figure 1. Schematic representation of the 3 × 3 × 3 supercell crystal structure of the (a) CsPbI\(_3\)Br, (b) CsPbI\(_{0.96}\)Eu\(_{0.04}\)I\(_2\)Br, and (c) CsPb\(_{0.05}\)In\(_{0.05}\)I\(_2\)Br and the corresponding (d–f) electronic band structures and (g–i) partial density of states.

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where $E_B$ is the binding energy, $E_{\text{total}}$ the total energy of pristine CsPbI$_2$Br, and $E_{\text{atom}}^i$ the energy of the free atom $i$ ($i = \text{Cs}, \text{Pb}, \text{I}, \text{Br}$, and dopant Eu or In); $n_i$ represents the number of atom $i$ in the supercell. The binding energies of CsPbI$_2$Br, CsPb$_{0.96}$Eu$_{0.04}$I$_2$Br, and CsPb$_{0.96}$In$_{0.04}$I$_2$Br are predicted to be $-2.68$, $-2.72$, and $-2.71$ eV per atom, respectively, indicating that Eu- and In-doped materials are thermodynamically more stable than the pristine CsPbI$_2$Br.

The calculated electronic band structures (Figure 1d–f) of CsPb$_{0.96}$Eu$_{0.04}$I$_2$Br and CsPb$_{0.96}$In$_{0.04}$I$_2$Br also indicate direct band gap materials, with band gap energies similar to those of the parent system ($\sim$1.9 eV). The calculated partial density of states (Figure 1g–i) show that compared to the Eu$^{2+}$-doped CsPbI$_2$Br, where the Fermi level remains closer to the valence band edge, In$^{3+}$ incorporation shifts the Fermi level closer to the conduction band edge and introduced donor states close to the bottom of the conduction band, which may be responsible for the improved electrical conductivity of In-doped CsPbI$_2$Br.$^{46,47}$ The effective masses ($m^*$) of holes and electrons are estimated by fitting the band edge using $m^*_h(e) = \pm \hbar^2 \frac{d^2E}{dk^2}^{-1}$. The prediction of relatively small effective masses (Table S1) suggests high mobility of electrons and holes at the band edges and consequently points to efficient extraction of charge carriers in the pristine and doped CsPbI$_2$Br materials.

Quality CsPbI$_2$Br perovskite thin films were deposited by the hot-air method (Supporting Note 1 and Figures S1–S3). X-ray diffraction (XRD) analyses of the control CsPbI$_2$Br thin film and samples doped with 5% Eu$^{2+}$ and In$^{3+}$ incorporation suggest only small changes in the lattice parameters. Structural refinement of the XRD data of the bare and doped CsPbI$_2$Br confirms the formation of the common orthorhombic $\gamma$-phase perovskite (Figure 2a, Supporting Note 2, and Figure S4). Samples developed with InCl$_3$ revealed a reduced unit cell volume, although Eu doping uncovered an expanded one, which is unexpected. Nonetheless, such structural changes suggest their incorporation into the parent lattice (further structural analysis provided below).$^{48}$

We recorded time-resolved photoluminescence (TRPL) and photoluminescence quantum yield (PLQY) from the perovskite materials deposited on glass substrates and on device-relevant substrates with isolated charge transport layers (CTLs) following a previous procedure.$^{49,50}$ With the help of
PLQY analysis, we can directly observe an increase in the quasi-Fermi level splitting (QFLS) which leads to improved device performance through an increase in $V_{OC}$. The change in the QFLS (herein $\Delta$QFLS) for solar cell materials has been calculated previously (Supporting Note 3). Figure 2b and Tables S2 and S3 show the detailed PLQY parameters of the bare and doped CsPbI$_2$Br thin films in contact with HTL and ETLs. We observe improvement in the $\Delta$PLQY values after Eu$^{2+}$ or In$^{3+}$ doping in the presence of both HTL and ETLs and also substantial gains for the CsPbI$_2$Br thin films coated on TiO$_2$ ETL, indicating nonradiative recombination in the n-i-p devices is the main factor limiting the open-circuit voltage. The PLQY is nearly 2 and 3 times larger for Eu- and In-doped films, respectively, with the expected gain of $\Delta$QFLS = 21.78 and 22.68 meV at the TiO$_2$/perovskite interface. Therefore, the doped samples are expected to exhibit enhanced $V_{OC}$ once implemented in complete devices. Emission lifetimes are extracted from the fluorescence-lifetime imaging microscopic (FLIM) images in Figure S5. TRPL decay profiles (Figure S5b) were measured at $\sim$640 nm to examine the kinetics of photogenerated excitons and free carriers. Parameters extracted from triexponential fitting are provided in Table S4, Supporting Note 4,55,56. The CsPbI$_2$Br, CsPb$_{0.95}$Eu$_{0.05}$I$_2$Br, and 0.25% InCl$_3$:CsPbI$_2$Br thin film compositions exhibit extensions in average lifetime $\langle \tau_{av} \rangle$ from 2.03 to 27 and 16 ns, respectively. The elongation of the PL decay can be ascribed to the synergetic effect of dense morphology, reduced grain boundary, compactness, limited defects, and metal ion-doped perovskite films.

Next, to investigate Eu$^{2+}$, In$^{3+}$, and Cl$^-$ incorporation within the perovskite lattice, we performed X-ray photoelectron spectroscopy (XPS) (Figures 2c–f and S6–S8). All samples exhibited Cs 3d, Pb 4f, I 3d, and Br 3d core levels at characteristic binding energies. However, we observed that the Pb 4f, I 3d, and Br 3d peaks are shifted to lower binding energy for CsPb$_{0.95}$Eu$_{0.05}$I$_2$Br and CsPbI$_2$Br samples, which is due to the formation of new Pb–X–Eu (X: Br and I) chemical bonding. Notably, the Cs 3d peak shows a negligible shift after Eu doping because of weak interaction between Cs$^+$ and the central atom (Eu) in the octahedron (see Supporting Note 5 and Table S2) (Figure 2d).58,59 For the case of InCl$_3$:CsPbI$_2$Br, apart from the parent element signatures (i.e., Cs$^+$, Pb$^{2+}$, I$^-$, and Br$^-$), the presence of In 3d (In 3d$_{5/2}$, 445.16; In 3d$_{3/2}$, 452.67 eV) and Cl 2p (200.79 eV) peaks confirms...
that In$^{3+}$ and Cl$^-$ are incorporated in the parent CsPbI$_2$Br lattice (Figure 2ef). Similar to the CsPb$_{0.95}$Eu$_{0.05}$I$_3$Br sample, we have also observed a corresponding shift in the Pb 4f, I 3d, and Br 3d peaks to lower binding energies, again being ascribed to the formation of new Pb–X–In (X: Br and I) bonds. It is also noted that the shift will remain relatively small because of the small amount of doping involved (0.25% InCl$_3$ doping concentration). Conversely, 2% InCl$_3$:CsPbI$_2$Br samples exhibited much more pronounced shifts, which evidently supports successful introduction of In (Figure S9 and Table S6).

Furthermore, high-angle annular dark-field scanning transmission electron microscopy (HAADF-STEM) mapping of the CsPb$_{0.95}$Eu$_{0.05}$I$_3$Br and InCl$_3$:CsPbI$_2$Br sample showed that the Eu$^{3+}$ and In$^{3+}$, along with Cl$^-$, are distributed uniformly within the perovskite grains at the atomic level. In addition, the uniformity of all other Cs, Pb, I, and Br elements is seen (Figures S10 and S11). Both XPS and HAADD-STEM analysis revealed that both Eu$^{3+}$ and In$^{3+}$ along with Cl$^-$ are incorporated evenly within the parent CsPbI$_2$Br lattice.

The UV–vis optical absorption spectra of the perovskite thin films deposited on the FTO/c-TiO$_2$/mp-TiO$_2$ substrate are shown in Figure S12. Black-phase CsPbI$_2$Br shows an absorption edge (∼640 nm/1.91 eV) which is slightly blue-shifted by the incorporation of the Eu$^{3+}$ and nearly without shift because of In$^{3+}$ inclusion. The electronic structures of the various layers were characterized by ultraviolet photoemission spectroscopy (UPS) (Figures 3a and S13). The work function (WF) and valence band maximum (VBM) were calculated from the binding energy cutoff ($E_{\text{cut-off}}$) and the binding energy onset ($E_{\text{onset}}$). The corresponding WF values of each layer were estimated to be 4.72, 4.68, 4.70, 4.03, and 5.08 eV for CsPbI$_2$Br, CsPb$_{0.95}$Eu$_{0.05}$I$_3$Br, InCl$_3$:CsPbI$_2$Br, InCl$_3$:CsPbI$_2$Br/P3HT, and InCl$_3$:CsPbI$_2$Br/CuSCN samples, respectively (Table S7). The VBM and CBM positions after Eu and InCl$_3$ doping did not change drastically, while the WF shifted by 210 and 60 meV toward the CB after Eu and InCl$_3$ doping, respectively. These results indicate the presence of additional negative charge carriers after Eu or In doping. Further, Eu and InCl$_3$ incorporation improved the energy level alignment of the conduction band minimum between the doped CsPbI$_2$Br perovskites and the ETL (Figure S14).

Energy level diagrams revealed the P3HT and CuSCN, with respect to doped CsPbI$_2$Br, matched favorably, resulting in efficient hole transportation. Therefore, it is expected that at the interface charge accumulation loss will be reduced and will help to improve the built-in potential across the perovskite film, resulting in higher $V_{OC}$ of the doped-CsPbI$_2$Br-based devices.

We pursue devices which have all of their layers deposited, annealed, and studied in an open atmosphere (except for gold deposition). Initially, we fabricated solar cells having the standard bilayered n-i-p device configuration, FTO/c-TiO$_2$/mp-TiO$_2$/CsPbI$_2$Br/CuSCN/Au (Figure 3a). For comparison, we also fabricated identical devices using CsPb$_{0.95}$Eu$_{0.05}$I$_3$Br and 0.25% InCl$_3$:CsPbI$_2$Br based on CuSCN HTL. The dopant-free CuSCN HTL has been deposited on annealed CsPbI$_2$Br perovskite thin film by a dynamic spin coating method from 35 mg mL$^{-1}$ DES solvent followed by rGO deposition.60,68 Figure 3c shows the $J–V$ characteristics of CuSCN-based CsPbI$_2$Br PSCs. The cross-sectional SEM images of the doped CsPbI$_2$Br thin films exhibit improved capping layer thickness from 300, 350 to 375 nm respectively for controlled, Eu$^{3+}$ and InCl$_3$-doped perovskite thin films (Figure S15). Interestingly, no grain boundaries in the cross-sectional image are observed, but rather we see the formation of a single crystalline-like layer.61 The perovskite device based on CsPbI$_2$Br perovskite film with CuSCN HTL delivers 12.01% PCE with $V_{OC}$ of 1.192 V, short-circuit current density ($J_{SC}$) of 14.06 mA cm$^{-2}$, and fill factor (FF) of 71.68%. In contrast, devices based on CsPb$_{0.95}$Eu$_{0.05}$I$_3$Br and InCl$_3$:CsPbI$_2$Br have increased $V_{OC}$ and $J_{SC}$ because of improved thickness and film quality. The optimized devices having FTO/ c-TiO$_2$/mp-TiO$_2$/CsPb$_{0.95}$Eu$_{0.05}$I$_3$Br/CuSCN/Au exhibits $V_{OC}$ of 1.249 V, $J_{SC}$ of 14.90 mA cm$^{-2}$, and FF of 73.76% and results in PCE of 13.72%. From cross-sectional SEM images, it is observed that both TiO$_2$/perovskite and perovskite/CuSCN interfaces are highly uniform, void-free, and smooth.

Interestingly, the hot-air method resulted in a >500 nm-thick layer which is typically difficult to achieve using conventional solution processing methods. For the case of trivalent In$^{3+}$ and Cl$^-$ codoping, the $V_{OC}$ is slightly higher than in the other devices and reaches 1.282 V with $J_{SC}$ of 15.91 mA cm$^{-2}$ and FF of 74.85% resulting in 15.27% PCE (Table S8). This improved performance is also reflected in the external quantum efficiency (EQE) spectra of CsPbI$_2$Br, CsPb$_{0.95}$Eu$_{0.05}$I$_3$Br, and InCl$_3$:CsPbI$_2$Br-based devices (Figure S16). Our champion device based on InCl$_3$:CsPbI$_2$Br produces ~90% EQE values, giving $J_{scat}$ of 15.20 mA cm$^{-2}$, which approaches the current values measured from $J–V$ curves.

Furthermore, the stabilized power output (SPO) of the champion devices were monitored for full sun illumination over 200 s (Figure S17). The steady-state photocurrent outputs for the CsPbI$_2$Br, CsPb$_{0.95}$Eu$_{0.05}$I$_3$Br, and InCl$_3$:CsPbI$_2$Br-based devices are 14.30, 14.63, and 15.64 mA cm$^{-2}$, respectively, and all exhibit $J_{SC}$ values close to those obtained from $J–V$ curves. The steady-state output values yielded stabilized PCE values of 12.02%, 13.61%, and

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**Table 1. Photovoltaic Performance Outcomes of Cells Fabricated from DHA Methods with Divalent (Eu$^{2+}$) and Trivalent (In$^{3+}$) Metal Ion-Doped CsPbI$_2$Br All-Inorganic Perovskites Using Dopant-Free CuSCN and P3HT HTLs**

<table>
<thead>
<tr>
<th>sample</th>
<th>HTL</th>
<th>$V_{OC}$ (V)</th>
<th>$J_{SC}$ (mA cm$^{-2}$)</th>
<th>FF (%)</th>
<th>PCE (%)</th>
</tr>
</thead>
<tbody>
<tr>
<td>CsPbI$_2$Br (control)</td>
<td>CuSCN</td>
<td>1.185</td>
<td>13.80</td>
<td>70.00</td>
<td>11.45</td>
</tr>
<tr>
<td>CsPbI$_2$Br (champion)</td>
<td>CuSCN</td>
<td>1.192</td>
<td>14.06</td>
<td>71.68</td>
<td>12.01</td>
</tr>
<tr>
<td>CsPb$<em>{0.95}$Eu$</em>{0.05}$I$_3$Br (control)</td>
<td>CuSCN</td>
<td>1.235</td>
<td>14.45</td>
<td>72.00</td>
<td>12.84</td>
</tr>
<tr>
<td>CsPb$<em>{0.95}$Eu$</em>{0.05}$I$_3$Br (champion)</td>
<td>CuSCN</td>
<td>1.249</td>
<td>14.90</td>
<td>73.76</td>
<td>13.72</td>
</tr>
<tr>
<td>0.25% InCl$_3$:CsPbI$_2$Br (control)</td>
<td>CuSCN</td>
<td>1.275</td>
<td>15.55</td>
<td>74.5</td>
<td>14.77</td>
</tr>
<tr>
<td>0.25% InCl$_3$:CsPbI$_2$Br (champion)</td>
<td>CuSCN</td>
<td>1.282</td>
<td>15.91</td>
<td>74.85</td>
<td>15.27</td>
</tr>
<tr>
<td>0.25% InCl$_3$:CsPbI$_2$Br (average)</td>
<td>P3HT</td>
<td>1.295</td>
<td>15.65</td>
<td>75.50</td>
<td>15.09</td>
</tr>
<tr>
<td>0.25% InCl$_3$:CsPbI$_2$Br (champion)</td>
<td>P3HT</td>
<td>1.303</td>
<td>15.90</td>
<td>75.76</td>
<td>15.69</td>
</tr>
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</table>
15.10% for CsPbI$_2$Br$_2$-, CsPb$_{0.95}$Eu$_{0.05}$I$_2$Br, and InCl$_3$:CsPbI$_2$Br-based devices, respectively. In contrast, the current density output of the bare CsPbI$_2$Br-based devices declined continuously, whereas the CsPb$_{0.95}$Eu$_{0.05}$I$_2$Br and InCl$_3$:CsPbI$_2$Br-based devices persisted far longer. This stabilized performance arises from the incorporation of metal cation doping, which stabilizes the photoactive black-phase (mechanism outlined below) and reduces the nonradiative recombination.

For charge transport measurements, we recorded the $V_{OC}$ as a function of illumination intensity for the examined perovskite devices (Figure 3d). The slope of the fitted data yields the ideality factor ($\eta$), which was determined by $V_{OC} = n k T \ln(I) / q + A$, where $k$, $T$, and $q$ are Boltzmann constant, the temperature in Kelvin, and the elementary charge, respectively. Parameter $A$ is a constant according to the Shockley–Read–Hall (SRH) recombination mechanism.$^{62–64}$ The above equation can be simplified for $\eta$ as, $\eta = \text{slope} \times \frac{A}{kT}$. It is considered that the trap-assisted recombination played a dominant role in determining the characteristics of devices at $\eta \approx 2$. Our controlled device gives $\eta$ values as high as 1.52, which decreased to 1.23 and 1.15 for CsPb$_{0.95}$Eu$_{0.05}$I$_2$Br and 0.25% InCl$_3$:CsPbI$_2$Br-based devices, respectively, indicating the suppression of charge recombination.

Figure 4. (a) Dopant-free P3HT HTL-based device configuration. (b) $J$–$V$ characteristics of InCl$_3$:CsPbI$_2$Br-based solar cells using dopant-free P3HT. (c) Ambient conditions device stability at 40–50% RH at 85 °C thermal stress of the 5 devices. (d) Steady-state current density and PCE of unencapsulated CsPbI$_2$Br and InCl$_3$:CsPbI$_2$Br devices monitored under continuous 1.5 AM solar-simulator illumination as a function of time. (e) Device performance distribution for dopant-free HTLs for InCl$_3$:CsPbI$_2$Br-based PSCs. (f) Distribution of PCE based on different dopant-free HTLs reported to date. Data has been extracted from refs 40, 43, 65, and 65.
Next, we monitored hysteresis and found control devices exhibited PCE values of 11.09% and 12.01% for the forward and reverse scans, respectively (Figure S1). In contrast, the CsPb_{0.8}Eu_{0.2}Br-based device exhibited 12.51% and 13.72% PCE in forward and reverse scan which is reduced because of highly uniform film quality. Further, we have also monitored the device performance of our champion InCl_{3}:CsPbI_{2}Br-based devices which exhibited J_{sc} of 15.61 mA cm^{-2}, V_{oc} of 1.262 V, and FF of 72.42%, resulting in PCE of 14.26% in the forward scan. On the other hand, the reverse scan exhibited 15.27% PCE with J_{sc} of 15.91 mA cm^{-2}, V_{oc} of 1.282 V, and FF of 74.85%; Table S8 indicates less hysteresis than the control architecture.

We selected the best performing devices from each composition and studied the air-stability of unencapsulated devices under continuous white light LED illumination, equivalent to 100 mW cm^{-2} in an ambient condition at 85 °C thermal stress. All devices were monitored under identical conditions; however, we have not regulated the environmental monitoring/control throughout the measurements. The stability analysis of these champion devices exhibited higher device performance due to excellent thermal stability properties of CuSCN HTL (Figure 3e). The bare CsPbI_{2}Br-based device maintained ∼60% initial efficiency after 1000 h; however, In^{3+} and Eu^{3+} incorporated devices retain over 75% and 87%, respectively, indicating excellent device stability.

P3HT is another low-cost HTL and can be used without any additive dopants, and we further examine its suitability for our developed champion InCl_{3}:CsPbI_{2}Br absorber composition (Figure 4a). These devices exhibited 14.83% (with V_{oc} = 1.277 V, J_{sc} = 15.90 mA cm^{-2}, and FF = 73.10%) and 15.69% (with V_{oc} = 1.303 V, J_{sc} = 15.91 mA cm^{-2}, and FF = 75.76%) for forward and reverse scans, respectively (Figure 4b and Table S9). The stability analysis revealed the P3HT devices also retain >95% of initial PCE over 1600 h, indicating excellent ambient stability under 85 °C thermal stress (Figure 4c). The photostability under 1 sun continuous illumination for several hours indicated the doped sample exhibited excellent photostability as compared to the control device (Figure 4d). The InCl_{3}:CsPbI_{2}Br/P3HT champion unencapsulated device was sent for third-party efficiency testing and was confirmed to exhibit a certified 14.97% PCE (see Figure S19).

For comparison, we have also fabricated conventional additive-doped spiro-MeOTAD-based devices and monitored their ambient stability (Figure S20). Unfortunately, even though we used expensive additive-based spiro-MeOTAD HTL, it shows lower efficiency. The best-performing device exhibited 13.70% PCE with V_{oc} = 1.197 V, J_{sc} = 15.81 mA cm^{-2}, and FF = 72.42%. This may be linked to the deposition of spiro-MeOTAD-based HTL under ambient conditions and its moisture instability. The ambient stability monitored under ambient conditions revealed sharp drops up to 50% within a few hours and retained only ∼20% of the initial PCE only after 100 h. This is due to the sensitive nature of additives-doped Spiro-MeOTAD HTL. Furthermore, we fabricated dopant-free spiro-MeOTAD-based devices, but these devices showed limited PCE (Figure S21).

Figures 4e and S22 show the statistical distribution of the PCEs in forward and reverse scan based on different compositions and methods. The statistical distribution of the PCE revealed high repeatability of the device performance. Interestingly, the reproducibility of the Eu^{3+} and In^{3+}-doped CsPbI_{2}Br-based devices were better in comparison to those prepared with the bare CsPbI_{2}Br compositions. For instance, in the CsPbI_{2}Br-based devices, we observed an average PCE of ∼12.2% with V_{oc} of 1.18 ± 0.01 V, J_{sc} of 14.21 mA cm^{-2}, and FF of 72 ± 2%; however, the CsPb_{0.8}Eu_{0.2}Br-based devices exhibited excellent reproducibility with V_{oc} of 1.250 ± 0.01 V, J_{sc} of 15.30 ± 0.5 mA cm^{-2}; and FF of 73 ± 2% yielding average efficiency >13.50 ± 0.1%. As expected, all 0.25% InCl_{3}:CsPbI_{2}Br-based devices exhibited higher current density with V_{oc} exceeding 1.30 V, which is due to the synergistic effect of hot-air method, metal-ion doping, and the suitability of the HTL.

We believe that our hot-air processed devices also exhibited state-of-the-art power conversion efficiency for dopant-free HTL-based devices (Figure 4f). We conclude that although there are a range of deposition methods and different dopant-free HTLs which can be explored, our combination of hot-air method with low-cost, dopant-free CuSCN and P3HT HTL-based devices embodies a promising route for high-efficiency devices that can be both processed and operated under fully ambient conditions. Among the previous methods used for inorganic perovskite solar cells to date, our work showed a record PCE of 15.69% for InCl_{3}:CsPbI_{2}Br composition and dopant-free P3HT HTL.

The stabilizing mechanism of metal doping in the normally unstable CsPbI_{2}Br parent perovskite system is yet to be discussed. Within a moisture-rich ambient atmosphere, water acts as a catalyst toward phase decay and δ-phase (non-perovskite) formation, partially dissolving the surface halide anions and introducing vacancies. As a result, the increased concentration of surface halide vacancies lowers the kinetic barrier and accelerates phase degradation, i.e., turning into the δ-phase. This is clearly tracked in Figures S23 and S24, showing the decay of the bare CsPbI_{2}Br perovskite thin films within hours of ambient storage. A complete transformation of the perovskite into the δ-phase is confirmed via structural refinement of the XRD patterns recorded after degradation, confirming the absence of any detectable crystalline side-products. This confirmed that the degradation mechanism under an ambient atmosphere is perovskite phase destabilization. The incorporation of InCl_{3} does little to slow a similar degradation pathway in an exposed thin film (i.e., no top contact layers attached); however, Eu is relatively successful in preserving the perovskite phase under the same conditions.

The change in stability cannot be accounted for purely based on a model which considers changes to the lattice tolerance factor, whereby reducing the unit cell volume (via B site doping) can increase the tolerance factor when the A and X sites remain unchanged. Similar stabilizing effects have been demonstrated recently for CsPbI_{3} doped with a few percent of Bi^{3+}. For phase transitions in which the high-symmetry α-phase is reduced to a degenerate γ-phase, the number of distortion components can be expressed in terms of symmetry-adapted strains. The decoupled strain components are presented in Figure S25 (Supporting Note 6). Starting with a bare γ-CsPbI_{2}Br perovskite, both InCl_{3} and Eu doping suppress the strain-related distortions in the perovskite crystal, making it more cubic-like (i.e., α-phase). Like the stabilizing effect of heating CsPbI_{2}Br toward a stable cubic perovskite structure, we suggest that the doping stabilizes the system because of a reversal of the spontaneous strains leading to phase decay. In addition, this effect is the largest for the Eu system, which we
Furthermore, we have recorded focused ion beam (FIB) cross-sectional images of the fabricated devices using the CsPbI\_2\_Br-based absorbers (Figure S26). To study degradation, we have obtained FIB images of the fresh devices (~10 h after fabrication) and after 14 days of aging. The FIB images of the freshly prepared devices exhibited formation of compact capping layers onto mp-TiO\_2 ETL. Interestingly, the P3HT layer is uniformly deposited and the perovskite/P3HT interface is smooth. In the present investigation, we have used doped CsPbI\_2\_Br perovskite compositions, which is free from conventional organic cations such as MAI, FAI, or DMAI. Therefore, there is less possibility of the formation of HI gases during degradation. However, we observed the formation of bright spots and dark voids in the CsPbI\_2\_Br-based materials, which revealed iodine degradation or halide ion-migration and the formation of CsPbI\_3 or PbI\_2. This is the most likely degradation of the bare CsPbI\_2\_Br-based devices. On the other hand, our CsPb\_0.95Eu\_0.05I\_2\_Br- and InCl\_3:CsPbI\_2\_Br-based devices exhibit an intact morphology of the capping layer even though we recorded them on devices aged for 14 days, indicating the devices were well-preserved.

In summary, we have utilized a simple hot-air method for the fabrication of high-quality CsPbI\_2\_Br thin films under ambient conditions. Our control over the deposition and the incorporation of Eu and In cations offers a new approach for stabilization of a functional CsPbI\_2\_Br black-phase in ambient air. The XRD, XPS, and STEM-HAADF analyses evidenced that the Eu and In cations are successfully incorporated into CsPbI\_2\_Br crystal which inhibits the black-to-yellow phase transformation by releasing spontaneous strains in the lattice. Our TRPL measurements revealed longer carrier life times due to Eu and In incorporation, indicating the passivation of traps. The fabricated InCl\_3:CsPbI\_2\_Br-based PSCs devices based on dopant-free, low-cost CuSCN and P3HT HTLs exhibited record PCEs of 15.27% and 15.69%, respectively. Long-term thermal analysis revealed more than 95% retention over 1600 h of operation under ambient conditions, which is much greater than the conventional additives-doped Spiro-MeOTAD HTL. We believe that our hot-air processed devices exhibited state-of-the-art power conversion efficiency in dopant-free HTL-based PSCs. These results provide new insights for the fabrication of high-quality cesium-based PSCs and low-cost dopant-free HTLs with excellent efficiency and air-thermal stability.

**ASSOCIATED CONTENT**

**Supporting Information**

The Supporting Information is available free of charge at https://pubs.acs.org/doi/10.1021/acsengleett.0c02385.

Full experimental procedures and device fabrication, DFT analysis details, materials, experimental methods, materials’ characterization, detailed discussion on methods and XPS analysis, PLQY calculations, TRPL analysis, HAADF-STEM, FIB, stability analysis, and testing (PDF)

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**Author Contributions**

S.S.M. and C.K.H. contributed to the conception and design of the experiments. S.S.M. fabricated all the devices and conducted most of the characterizations. S.S.M. and C.K.H. wrote the manuscript. J.V.P. and G.M. participated in writing the manuscript. S.S.M., S.R.R., and N.Y.D. carried out DFT analysis and discussed results. J.A.S. carried out XRD refinement and analysis. All authors discussed the results and reviewed the manuscript.

**Notes**

The authors declare no competing financial interest.

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